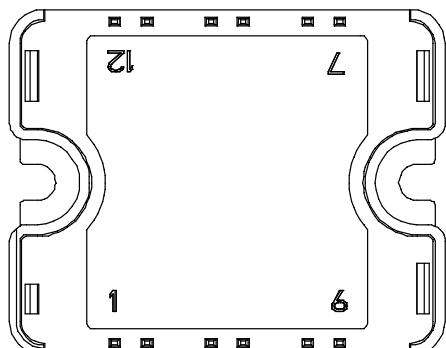
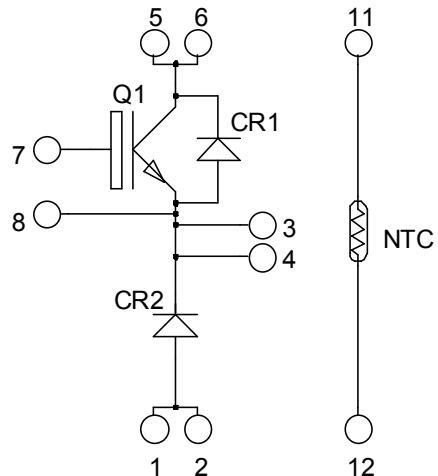


**Buck chopper
Trench + Field Stop IGBT®
Power Module**

**V_{CES} = 600V
I_C = 100A* @ T_c = 80°C**



Pins 1/2 ; 3/4 ; 5/6 must be shorted together

Absolute maximum ratings

Symbol	Parameter	Max ratings	Unit	
V _{CES}	Collector - Emitter Breakdown Voltage	600	V	
I _C	Continuous Collector Current	T _c = 25°C T _c = 80°C	A	150 * 100 *
I _{CM}	Pulsed Collector Current	T _c = 25°C		200
V _{GE}	Gate – Emitter Voltage		±20	
P _D	Maximum Power Dissipation	T _c = 25°C	W	
RBSOA	Reverse Bias Safe Operating Area	T _j = 150°C	200A @ 550V	

Specification of IGBT device but output current must be limited to 75A to not exceed a delta of temperature greater than 30°C for the connectors.

 **CAUTION:** These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com

All ratings @ $T_j = 25^\circ\text{C}$ unless otherwise specified

Electrical Characteristics

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
I_{CES}	Zero Gate Voltage Collector Current	$V_{GE} = 0\text{V}$, $V_{CE} = 600\text{V}$			250	μA
$V_{CE(\text{sat})}$	Collector Emitter Saturation Voltage	$V_{GE} = 15\text{V}$	$T_j = 25^\circ\text{C}$	1.5	1.9	V
		$I_C = 100\text{A}$	$T_j = 150^\circ\text{C}$	1.7		
$V_{GE(\text{th})}$	Gate Threshold Voltage	$V_{GE} = V_{CE}$, $I_C = 1.5 \text{ mA}$	5.0	5.8	6.5	V
I_{GES}	Gate – Emitter Leakage Current	$V_{GE} = 20\text{V}$, $V_{CE} = 0\text{V}$			400	nA

Dynamic Characteristics

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
C_{ies}	Input Capacitance	$V_{GE} = 0\text{V}$ $V_{CE} = 25\text{V}$ $f = 1\text{MHz}$		6100		pF
C_{oes}	Output Capacitance			390		
C_{res}	Reverse Transfer Capacitance			190		
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching (25°C) $V_{GE} = \pm 15\text{V}$ $V_{Bus} = 300\text{V}$ $I_C = 100\text{A}$ $R_G = 3.3\Omega$		115		ns
T_r	Rise Time			45		
$T_{d(off)}$	Turn-off Delay Time			225		
T_f	Fall Time			55		
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching (150°C) $V_{GE} = \pm 15\text{V}$ $V_{Bus} = 300\text{V}$ $I_C = 100\text{A}$ $R_G = 3.3\Omega$		130		ns
T_r	Rise Time			50		
$T_{d(off)}$	Turn-off Delay Time			300		
T_f	Fall Time			70		
E_{on}	Turn on Energy	$V_{GE} = \pm 15\text{V}$ $V_{Bus} = 300\text{V}$ $I_C = 100\text{A}$	$T_j = 25^\circ\text{C}$	0.4		mJ
E_{off}	Turn off Energy		$T_j = 150^\circ\text{C}$	0.875		

Chopper diode ratings and characteristics

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit	
V_{RRM}	Maximum Peak Repetitive Reverse Voltage		600			V	
I_{RM}	Maximum Reverse Leakage Current	$V_R = 600\text{V}$	$T_j = 25^\circ\text{C}$		250	μA	
			$T_j = 150^\circ\text{C}$		500		
I_F	DC Forward Current		$T_c = 80^\circ\text{C}$	100		A	
V_F	Diode Forward Voltage	$I_F = 100\text{A}$ $V_{GE} = 0\text{V}$	$T_j = 25^\circ\text{C}$	1.6	2	V	
			$T_j = 150^\circ\text{C}$	1.5			
t_{rr}	Reverse Recovery Time	$I_F = 100\text{A}$ $V_R = 300\text{V}$ $di/dt = 2000\text{A}/\mu\text{s}$	$T_j = 25^\circ\text{C}$	125		ns	
			$T_j = 150^\circ\text{C}$	220			
Q_{rr}	Reverse Recovery Charge		$T_j = 25^\circ\text{C}$	4.7		μC	
			$T_j = 150^\circ\text{C}$	9.9			
E_r	Reverse Recovery Energy		$T_j = 25^\circ\text{C}$	1.1		mJ	
			$T_j = 150^\circ\text{C}$	2.4			

Thermal and package characteristics
Symbol **Characteristic**

			Min	Typ	Max	Unit
R_{thJC}	Junction to Case Thermal Resistance	IGBT			0.44	°C/W
		Diode			0.77	
V_{ISOL}	RMS Isolation Voltage, any terminal to case t=1 min, I isol<1mA, 50/60Hz	2500				V
T_J	Operating junction temperature range	-40		175		°C
T_{STG}	Storage Temperature Range	-40		125		
T_C	Operating Case Temperature	-40		100		
Torque	Mounting torque	To heatsink	M4	2.5	4.7	N.m
Wt	Package Weight				80	g

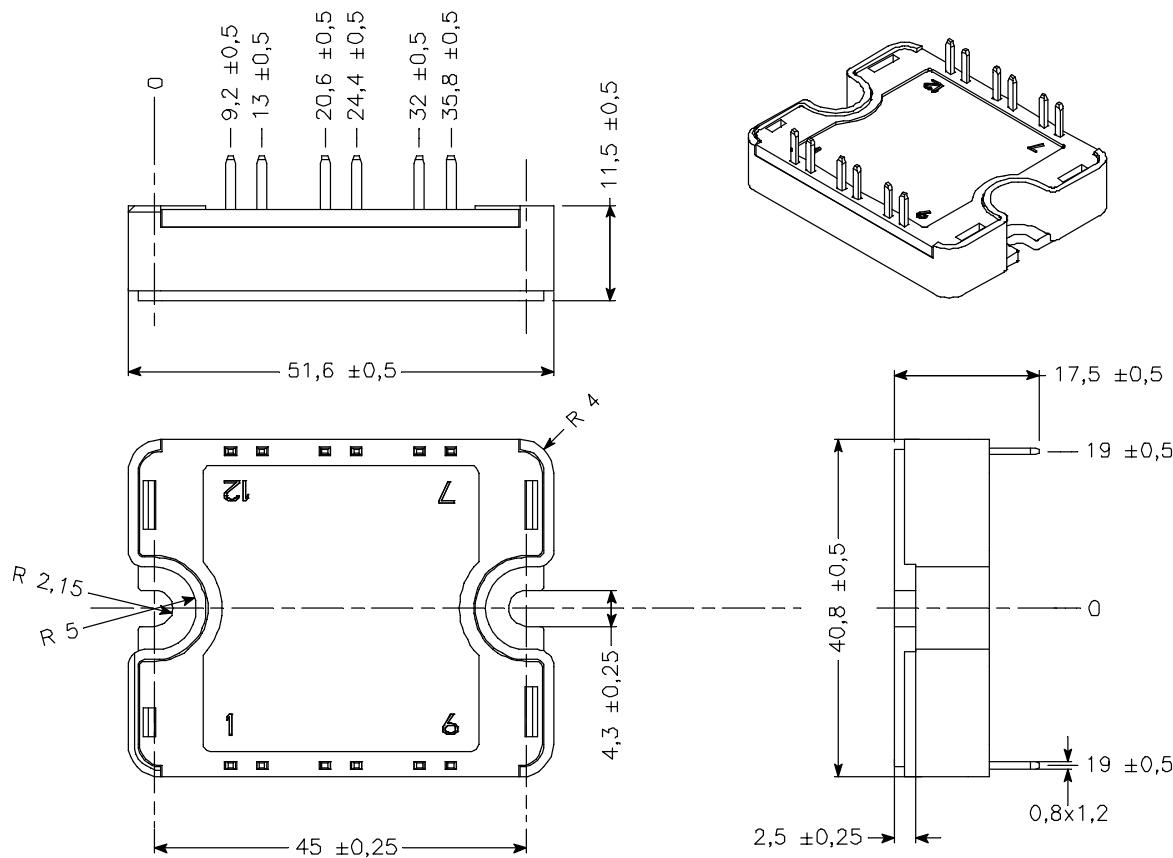
Temperature sensor NTC (see application note APT0406 on www.microsemi.com for more information).

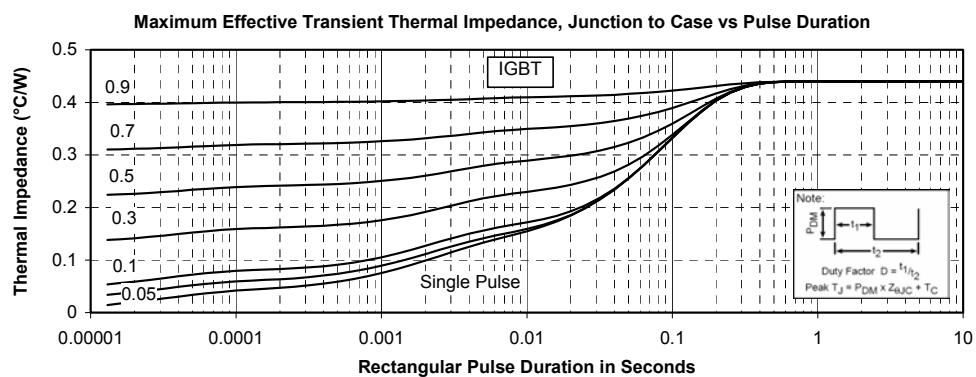
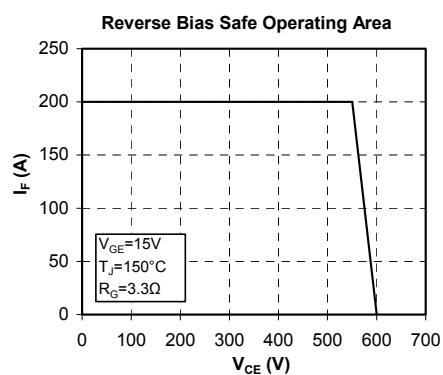
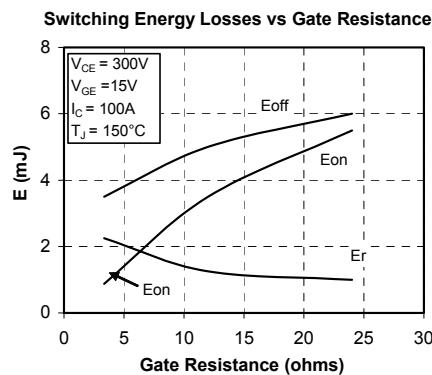
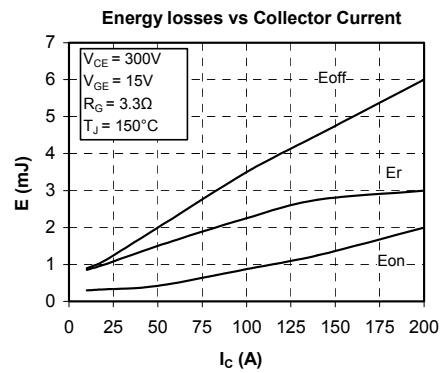
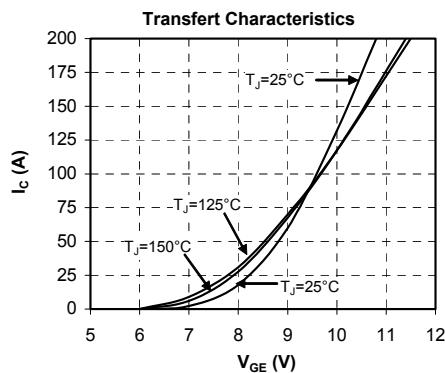
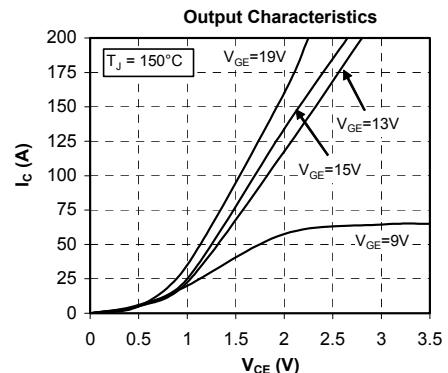
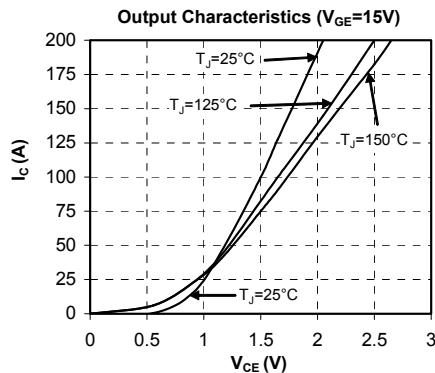
Symbol **Characteristic**

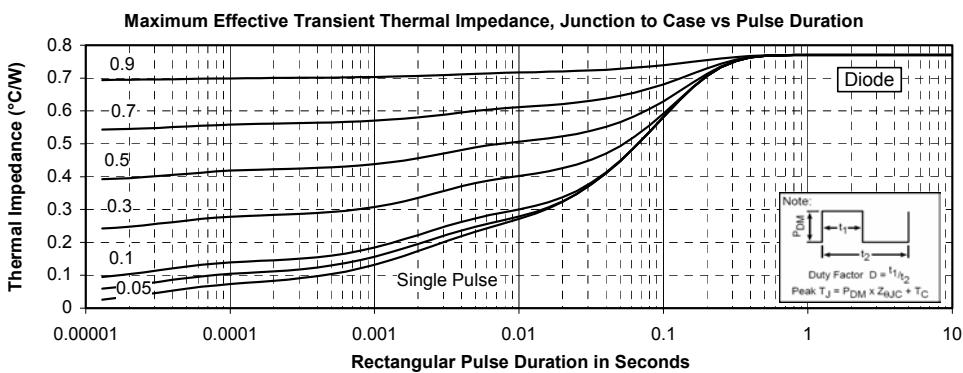
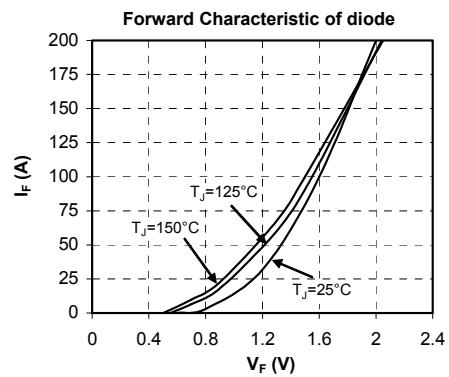
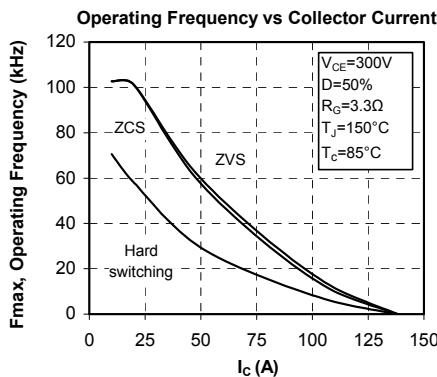
		Min	Typ	Max	Unit
R_{25}	Resistance @ 25°C		50		kΩ
$B_{25/85}$	$T_{25} = 298.15 \text{ K}$		3952		K

$$R_T = \frac{R_{25}}{\exp\left[B_{25/85}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]}$$

T: Thermistor temperature
R_T: Thermistor value at T

SP1 Package outline (dimensions in mm)

 See application note 1904 - Mounting Instructions for SP1 Power Modules on www.microsemi.com

Typical Performance Curve




Microsemi reserves the right to change, without notice, the specifications and information contained herein

Microsemi's products are covered by one or more of U.S patents 4,895,810 5,045,903 5,089,434 5,182,234 5,019,522 5,262,336 6,503,786 5,256,583 4,748,103 5,283,202 5,231,474 5,434,095 5,528,058 and foreign patents. U.S and Foreign patents pending. All Rights Reserved.